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- 2-V to 5.5-V V_{CC} Operation
- Support Mixed-Mode Voltage Operation on All Ports
- High On-Off Output-Voltage Ratio
- Low Crosstalk Between Switches
- Individual Switch Controls
- Extremely Low Input Current
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)

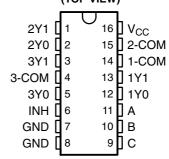
description/ordering information

These triple 2-channel CMOS analog multiplexers/demultiplexers are designed for 2-V to 5.5-V V_{CC} operation.

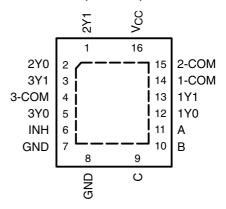
The 'LV4053A devices handle both analog and digital signals. Each channel permits signals with amplitudes up to 5.5 V (peak) to be transmitted in either direction.

Applications include signal gating, chopping, modulation or demodulation (modem), and signal multiplexing for analog-to-digital and digital-to-analog conversion systems.

SN54LV4053A . . . J OR W PACKAGE SN74LV4053A . . . D, DB, DGV, N, NS, OR PW PACKAGE (TOP VIEW)



SN74LV4053A ... RGY PACKAGE (TOP VIEW)



ORDERING INFORMATION

T _A	PACK	AGE [†]	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	PDIP – N	Tube of 25	SN74LV4053AN	SN74LV4053AN
	QFN – RGY	Reel of 1000	SN74LV4053ARGYR	LW053A
	0010 D	Tube of 40	SN74LV4053AD	11/40504
	SOIC – D	Reel of 2500	SN74LV4053ADR	LV4053A
4000 +- 0500	SOP - NS	Reel of 2000	SN74LV4053ANSR	74LV4053A
–40°C to 85°C	SSOP – DB	Reel of 2000	SN74LV4053ADBR	LW053A
		Tube of 90	SN74LV4053APW	
	TSSOP - PW	Reel of 2000	SN74LV4053APWR	LW053A
		Reel of 250	SN74LV4053APWT	
	TVSOP - DGV	Reel of 2000	SN74LV4053ADGVR	LW053A
-55°C to 125°C	CDIP – J	Tube of 25	SNJ54LV4053AJ	SNJ54LV4053AJ
-55 C to 125°C	CFP – W	Tube of 150	SNJ54LV4053AW	SNJ54LV4053AW

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

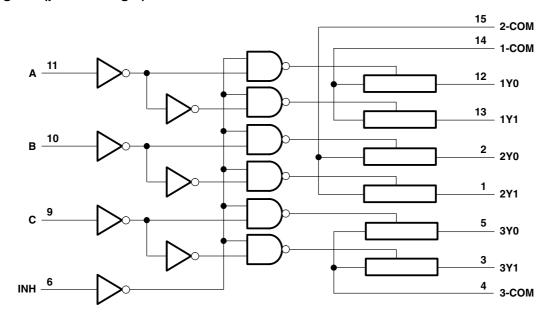


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FUNCTION TABLE

	INP	ON OUANNELO		
INH	С	В	Α	ON CHANNELS
L	L	L	L	1Y0, 2Y0, 3Y0
L	L	L	Н	1Y1, 2Y0, 3Y0
L	L	Н	L	1Y0, 2Y1, 3Y0
L	L	Н	Н	1Y1, 2Y1, 3Y0
L	Н	L	L	1Y0, 2Y0, 3Y1
L	Н	L	Н	1Y1, 2Y0, 3Y1
L	Н	Н	L	1Y0, 2Y1, 3Y1
L	Н	Н	Н	1Y1, 2Y1, 3Y1
Н	Χ	Χ	Χ	None

logic diagram (positive logic)



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V _I (see Note 1)	–0.5 V to 7 V
Switch I/O voltage range, V _{IO} (see Notes 1 and 2)	–0.5 V to V_{CC} + 0.5 V
Input clamp current, $I_{ K }(V_1 < 0)$	–20 mA
I/O diode current, I _{IOK} (V _{IO} < 0)	–50 mA
Switch through current, I _T (V _{IO} = 0 to V _{CC})	±25 mA
Continuous current through V _{CC} or GND	±50 mA
Package thermal impedance, θ_{JA} (see Note 3): D package	73°C/W
(see Note 3): DB package	82°C/W
(see Note 3): DGV package	120°C/W
(see Note 3): NS package	64°C/W
(see Note 3): PW package	108°C/W
(see Note 4): RGY package	39°C/W
Storage temperature range, T _{stq}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

- 2. This value is limited to 5.5 V maximum.
- 3. The package thermal impedance is calculated in accordance with JESD 51-7.
- 4. The package thermal impedance is calculated in accordance with JESD 51-5.

recommended operating conditions (see Note 5)

			SN54LV	4053A	SN74LV	/4053A		
			MIN	MAX	MIN	MAX	UNIT	
V_{CC}	Supply voltage		2 [‡]	5.5	2‡	5.5	V	
		V _{CC} = 2 V	1.5		1.5			
.,	High land in a line of the second second in the second	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	$V_{CC} \times 0.7$		$V_{CC} \times 0.7$.,	
V_{IH}	High-level input voltage, control inputs	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$	$V_{CC} \times 0.7$		$V_{CC} \times 0.7$		V	
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	$V_{CC} \times 0.7$:h	$V_{CC} \times 0.7$			
		V _{CC} = 2 V		0.5		0.5		
.,		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	v	
V_{IL}	Low-level input voltage, control inputs	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$	ć	$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	V	
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	20	$V_{CC} \times 0.3$		$V_{CC} \times 0.3$		
VI	Control input voltage		0	5.5	0	5.5	V	
V_{IO}	Input/output voltage		0	V_{CC}	0	V _{CC}	V	
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		200		200		
Δt/Δν	Input transition rise or fall rate	V _{CC} = 3 V to 3.6 V		100		100	ns/V	
		V _{CC} = 4.5 V to 5.5 V		20		20		
T_A	Operating free-air temperature		-55	125	-40	85	°C	

[‡] With supply voltages at or near 2 V, the analog switch on-state resistance becomes very nonlinear. It is recommended that only digital signals be transmitted at these low supply voltages.

NOTE 5: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	DADAMETED	TEST	.,	T,	_A = 25°C)	SN54LV	/4053A	SN74LV	4053A	
	PARAMETER	CONDITIONS	v _{cc}	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
		I _T = 2 mA,	2.3 V		41	180		225		225	
r _{on}	On-state switch resistance	$V_I = V_{CC}$ or GND, $V_{INH} = V_{IL}$	3 V		30	150		190		190	Ω
	ownorr redictarioe	(see Figure 1)	4.5 V		23	75		100		100	
		I _T = 2 mA,	2.3 V		139	500		600		600	
r _{on(p)}	Peak on-state resistance	$V_I = V_{CC}$ to GND,	3 V		63	180		225		225	Ω
		$V_{INH} = V_{IL}$	4.5 V		35	100		125		125	
	Difference in	I _T = 2 mA,	2.3 V		2	30		40		40	
Δr_{on}	on-state resistance	$V_I = V_{CC}$ to GND,	3 V		1.6	20		30		30	Ω
	between switches	$V_{INH} = V_{IL}$	4.5 V		1.3	15		20		20	
II	Control input current	V _I = 5.5 V or GND	0 to 5.5 V			±0.1		±1		±1	μА
I _{S(off)}	Off-state switch leakage current	$\begin{aligned} &V_I = V_{CC} \text{ and } \\ &V_O = \text{GND, or } \\ &V_I = \text{GND and } \\ &V_O = V_{CC}, \\ &V_{INH} = V_{IH} \\ &(\text{see Figure 2}) \end{aligned}$	5.5 V			±0.1	Z LONGOW	±1		±1	μΑ
I _{S(on)}	On-state switch leakage current	$V_I = V_{CC}$ or GND, $V_{INH} = V_{IH}$ (see Figure 3)	5.5 V			±0.1		±1		±1	μА
I _{CC}	Supply current	$V_I = V_{CC}$ or GND	5.5 V					20		20	μΑ
C _{IC}	Control input capacitance				2						pF
C _{IS}	Common terminal capacitance				8.2						pF
C _{OS}	Switch terminal capacitance				5.6						pF
C _F	Feedthrough capacitance				0.5						pF

switching characteristics over recommended operating free-air temperature range, V_{CC} = 2.5 V \pm 0.2 V (unless otherwise noted)

DAI	DAMETER	FROM	то	TEST	T,	չ = 25°C		SN54LV4053A	SN74LV4053A	LINUT
PAI	RAMETER	(INPUT)	(OUTPUT) CONDITIONS		MIN	TYP	MAX	MIN MAX	MIN MAX	UNIT
t _{PLH} t _{PHL}	Propagation delay time	COM or Yn	Yn or COM	C _L = 15 pF (see Figure 4)		2.5	10	16	16	ns
t _{PZH}	Enable delay time	INH	COM or Yn	C _L = 15 pF (see Figure 5)		7.6	18	23	23	ns
t _{PHZ}	Disable delay time	INH	COM or Yn	C _L = 15 pF (see Figure 5)		7.7	18	23	23	ns
t _{PLH} t _{PHL}	Propagation delay time	COM or Yn	Yn or COM	C _L = 50 pF (see Figure 4)		4.4	12	18	18	ns
t _{PZH}	Enable delay time	INH	COM or Yn	$C_L = 50 \text{ pF}$ (see Figure 5)		8.8	28	35	35	ns
t _{PHZ} t _{PLZ}	Disable delay time	INH	COM or Yn	$C_L = 50 \text{ pF}$ (see Figure 5)		11.7	28	35	35	ns



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switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted)

DA.	DAMETER	FROM	то	TEST	T,	չ = 25°C	;	SN54LV4	053A	SN74LV	4053A	LINUT
PAI	RAMETER	(INPUT)	(OUTPUT)	CONDITIONS	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
t _{PLH} t _{PHL}	Propagation delay time	COM or Yn	Yn or COM	C _L = 15 pF (see Figure 4)		1.6	6		10		10	ns
t _{PZH} t _{PZL}	Enable delay time	INH	COM or Yn	$C_L = 15 pF$ (see Figure 5)		5.3	12		15		15	ns
t _{PHZ}	Disable delay time	INH	COM or Yn	$C_L = 15 pF$ (see Figure 5)		6.1	12	"Add	15		15	ns
t _{PLH} t _{PHL}	Propagation delay time	COM or Yn	Yn or COM	C _L = 50 pF (see Figure 4)		2.9	9	'ona	12		12	ns
t _{PZH}	Enable delay time	INH	COM or Yn	$C_L = 50 \text{ pF}$ (see Figure 5)		6.1	20) Ha	25		25	ns
t _{PHZ}	Disable delay time	INH	COM or Yn	$C_L = 50 \text{ pF}$ (see Figure 5)		8.9	20		25		25	ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted)

DA	DAMETED	FROM	то	TO TEST		√ = 25°C	;	SN54LV4053	SN74L	V4053A	
PAI	RAMETER	(INPUT)	(OUTPUT)	CONDITIONS	MIN	TYP	MAX	MIN MA	(MIN	MAX	UNIT
t _{PLH} t _{PHL}	Propagation delay time	COM or Yn	Yn or COM	C _L = 15 pF (see Figure 4)		0.9	4		7	7	ns
t _{PZH}	Enable delay time	INH	COM or Yn	C _L = 15 pF (see Figure 5)		3.8	8	Tall.	0	10	ns
t _{PHZ}	Disable delay time	INH	COM or Yn	$C_L = 15 pF$ (see Figure 5)		4.6	8		0	10	ns
t _{PLH} t _{PHL}	Propagation delay time	COM or Yn	Yn or COM	C _L = 50 pF (see Figure 4)		1.8	6	'Sna	3	8	ns
t _{PZH} t _{PZL}	Enable delay time	INH	COM or Yn	$C_L = 50 \text{ pF}$ (see Figure 5)		4.3	14	1	3	18	ns
t _{PHZ} t _{PLZ}	Disable delay time	INH	COM or Yn	$C_L = 50 \text{ pF}$ (see Figure 5)		6.3	14	1	3	18	ns

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analog switch characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CON	IDITIONS	v _{cc}	T _A = 25°C	UNIT
			C _L = 50 pF,		2.3 V	30	
Frequency response (switch on)	COM or Yn	Yn or COM	$R_L = 600 \Omega$, $f_{in} = 1 \text{ MHz (sine)}$	wave)	3 V	35	MHz
(ermen err)			(see Note 6 and I	,	4.5 V	50	
	$C_L = 50 \text{ pF},$			2.3 V	-45		
Crosstalk (between any switches)	COM or Yn	Yn or COM	M $R_L = 600 \Omega$, $f_{in} = 1 \text{ MHz (sine wave)}$		3 V	-45	dB
(comes, any construct)	(see Note 7 and Fig			4.5 V	-45		
			$C_L = 50 \text{ pF},$		2.3 V	20	mV
Crosstalk (control input to signal output)	INH	COM or Yn	$R_L = 600 \Omega$, $f_{in} = 1 MHz$ (squa	3 V	35		
(control input to digital datput)			(see Figure 8)	4.5 V	65		
			C _L = 50 pF,		2.3 V	-45	dB
Feedthrough attenuation (switch off)	COM or Yn	Yn or COM	$R_L = 600 \Omega$, $f_{in} = 1 MHz$		3 V	-45	
(critical cit)			(see Note 7 and I	Figure 9)	4.5 V	-45	
			$C_L = 50 \text{ pF},$ $R_L = 10 \text{ k}\Omega,$	V _I = 2 V _{p-p}	2.3 V	0.1	
Sine-wave distortion	COM or Yn	Yn or COM	f _{in} = 1 kHz	$V_{I} = 2.5 V_{p-p}$	3 V	0.1	%
			(sine wave) (see Figure 10)	$V_I = 4 V_{p-p}$	4.5 V	0.1	

NOTES: 6. Adjust f_{in} voltage to obtain 0-dBm output. Increase f_{in} frequency until dB meter reads -3 dB.

operating characteristics, V_{CC} = 3.3 V, T_A = 25°C

	PARAMETER	TEST CO	NDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	$C_L = 50 pF$,	f = 10 MHz	5.3	pF

PARAMETER MEASUREMENT INFORMATION

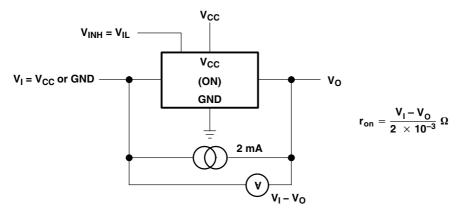
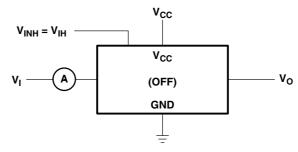


Figure 1. On-State Resistance Test Circuit

^{7.} Adjust fin voltage to obtain 0-dBm input.

PARAMETER MEASUREMENT INFORMATION



Condition 1: $V_I = 0$, $V_O = V_{CC}$ Condition 2: $V_I = V_{CC}$, $V_O = 0$

Figure 2. Off-State Switch Leakage-Current Test Circuit

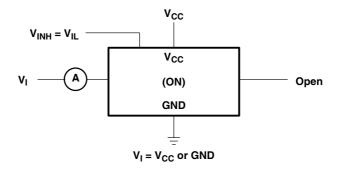


Figure 3. On-State Switch Leakage-Current Test Circuit

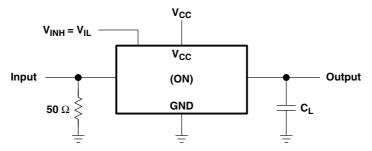
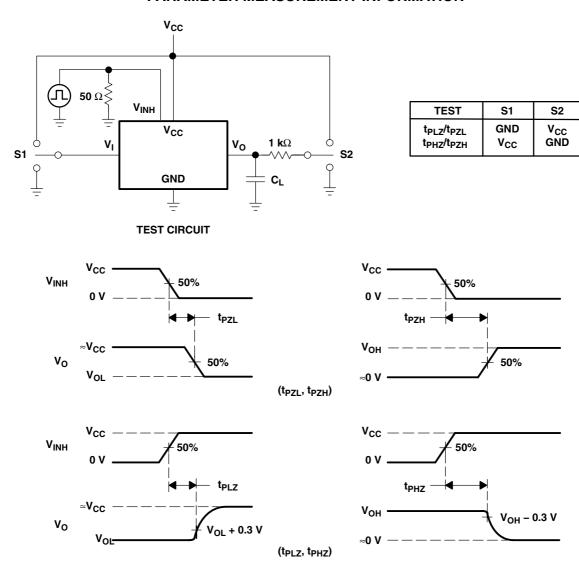


Figure 4. Propagation Delay Time, Signal Input to Signal Output

PARAMETER MEASUREMENT INFORMATION



VOLTAGE WAVEFORMS

Figure 5. Switching Time (t_{PZL}, t_{PLZ}, t_{PZH}, t_{PHZ}), Control to Signal Output

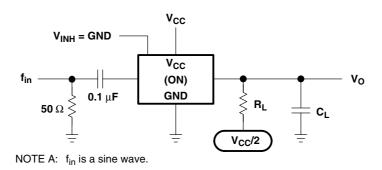


Figure 6. Frequency Response (Switch On)



PARAMETER MEASUREMENT INFORMATION

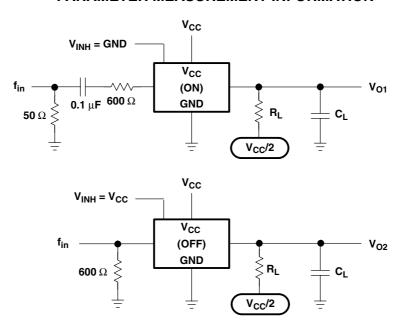


Figure 7. Crosstalk Between Any Two Switches

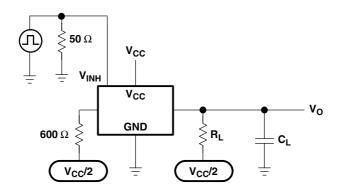


Figure 8. Crosstalk Between Control Input and Switch Output

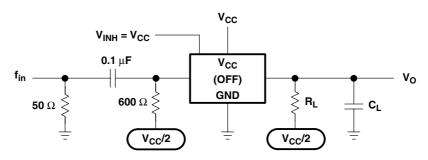


Figure 9. Feedthrough Attenuation (Switch Off)

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PARAMETER MEASUREMENT INFORMATION

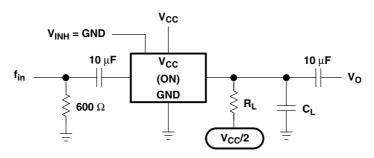


Figure 10. Sine-Wave Distortion

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74LV4053AD	ACTIVE	SOIC	D	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LV4053A	Samples
SN74LV4053ADBR	ACTIVE	SSOP	DB	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LW053A	Samples
SN74LV4053ADE4	ACTIVE	SOIC	D	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LV4053A	Samples
SN74LV4053ADGVR	ACTIVE	TVSOP	DGV	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LW053A	Samples
SN74LV4053ADR	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU SN	Level-1-260C-UNLIM	-40 to 85	LV4053A	Samples
SN74LV4053AN	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74LV4053AN	Samples
SN74LV4053ANSR	ACTIVE	SO	NS	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	74LV4053A	Samples
SN74LV4053APW	ACTIVE	TSSOP	PW	16	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LW053A	Samples
SN74LV4053APWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU SN	Level-1-260C-UNLIM	-40 to 85	LW053A	Samples
SN74LV4053APWRG4	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LW053A	Samples
SN74LV4053APWT	ACTIVE	TSSOP	PW	16	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LW053A	Samples
SN74LV4053ARGYR	ACTIVE	VQFN	RGY	16	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	LW053A	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

PACKAGE OPTION ADDENDUM

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(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN74LV4053A:

Automotive: SN74LV4053A-Q1

■ Enhanced Product : SN74LV4053A-EP

NOTE: Qualified Version Definitions:

Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

• Enhanced Product - Supports Defense, Aerospace and Medical Applications



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TAPE AND REEL INFORMATION



TAPE DIMENSIONS + K0 - P1 - B0 W Cavity - A0 -

A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LV4053ADBR	SSOP	DB	16	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
SN74LV4053ADGVR	TVSOP	DGV	16	2000	330.0	12.4	6.8	4.0	1.6	8.0	12.0	Q1
SN74LV4053ADR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
SN74LV4053ADR	SOIC	D	16	2500	330.0	16.8	6.5	10.3	2.1	8.0	16.0	Q1
SN74LV4053ANSR	so	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74LV4053APWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV4053APWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV4053APWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV4053APWT	TSSOP	PW	16	250	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV4053ARGYR	VQFN	RGY	16	3000	330.0	12.4	3.8	4.3	1.5	8.0	12.0	Q1



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*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins SPQ		Length (mm)	Width (mm)	Height (mm)	
SN74LV4053ADBR	SSOP	DB	16	2000	356.0	356.0	35.0	
SN74LV4053ADGVR	TVSOP	DGV	16	2000	356.0	356.0	35.0	
SN74LV4053ADR	SOIC	D	16	2500	340.5	336.1	32.0	
SN74LV4053ADR	SOIC	D	16	2500	364.0	364.0	27.0	
SN74LV4053ANSR	SO	NS	16	2000	356.0	356.0	35.0	
SN74LV4053APWR	TSSOP	PW	16	2000	364.0	364.0	27.0	
SN74LV4053APWR	TSSOP	PW	16	2000	356.0	356.0	35.0	
SN74LV4053APWRG4	TSSOP	PW	16	2000	367.0	367.0	35.0	
SN74LV4053APWT	TSSOP	PW	16	250	356.0	356.0	35.0	
SN74LV4053ARGYR	VQFN	RGY	16	3000	367.0	367.0	35.0	

PACKAGE MATERIALS INFORMATION

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TUBE



*All dimensions are nominal

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Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN74LV4053AD	D	SOIC	16	40	507	8	3940	4.32
SN74LV4053ADE4	D	SOIC	16	40	507	8	3940	4.32
SN74LV4053AN	N	PDIP	16	25	506	13.97	11230	4.32
SN74LV4053AN	N	PDIP	16	25	506	13.97	11230	4.32
SN74LV4053APW	PW	TSSOP	16	90	530	10.2	3600	3.5



SOP



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.



SOF



NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOF



NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
 4. Reference JEDEC registration MO-150.





NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



DGV (R-PDSO-G**)

24 PINS SHOWN

PLASTIC SMALL-OUTLINE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



RGY (R-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

4206353-3/P 03/14

NOTE: All linear dimensions are in millimeters



RGY (R-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



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